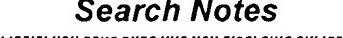


<b>Search Notes</b> 	<b>Application/Control No.</b> 10/632,456	<b>Applicant(s)/Patent under Reexamination</b> YEH ET AL.
	<b>Examiner</b>	<b>Art Unit</b>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	531	29 July 2005	AKA